

Notice of References Cited	Application/Control No. 10/509,795	Applicant(s)/Patent Under Reexamination OHI ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
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	G	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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*	N	WO 2002010137 A2	02-2002	World Intellect	BHAGWAT et al.	
*	O	WO 2003064397 A1	08-2003	World Intellect	BINCH et al.	
*	P	WO 2001053268 A2	07-2001	World Intellect	REICH et al.	
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Partridge et al. Abstract from Journal of the Chemical Society 1964, 3663-9. *CAS Abstract Provided.
*	V	Burmistrov et al. Abstract from Khimiya Geterotsiklicheskikh Soedinenii 1973, 2, 249-51. *CAS Abstract Provided.
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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